

Normally – OFF Silicon Carbide Junction Transistor

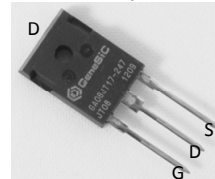
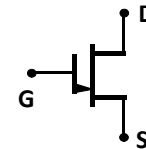
V_{DS}	=	1700 V
$V_{DS(ON)}$	=	2.0 V
I_D	=	8 A
$R_{DS(ON)}$	=	250 mΩ

Features

- 175 °C maximum operating temperature
- Temperature independent switching performance
- Gate oxide free SiC switch
- Suitable for connecting an anti-parallel diode
- Positive temperature coefficient for easy paralleling
- Low gate charge
- Low intrinsic capacitance

Package

- RoHS Compliant


TO-247AB


Advantages

- Low switching losses
- Higher efficiency
- High temperature operation
- High short circuit withstand capability

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

Maximum Ratings unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Drain – Source Voltage	V_{DS}	$V_{GS} = 0 V$	1700	V
Continuous Drain Current	I_D	$T_{C,MAX} = 90\text{ °C}$	8	A
Gate Peak Current	I_{GM}		5	A
Turn-Off Safe Operating Area	RBSOA	$T_{VJ} = 175\text{ °C}$, $I_G = 1 A$, Clamped Inductive Load	$I_{D,max} = 8$ @ $V_{DS} \leq V_{DSmax}$	A
Short Circuit Safe Operating Area	SCSOA	$T_{VJ} = 175\text{ °C}$, $I_G = 1 A$, $V_{DS} = 1200 V$, Non Repetitive	20	μs
Reverse Gate – Source Voltage	V_{SG}		30	V
Reverse Drain – Source Voltage	V_{SD}		50	V
Power Dissipation	P_{tot}	$T_C = 25\text{ °C}$	146	W
Storage Temperature	T_{stg}		-55 to 175	°C

Electrical Characteristics at $T_j = 175\text{ °C}$, unless otherwise specified

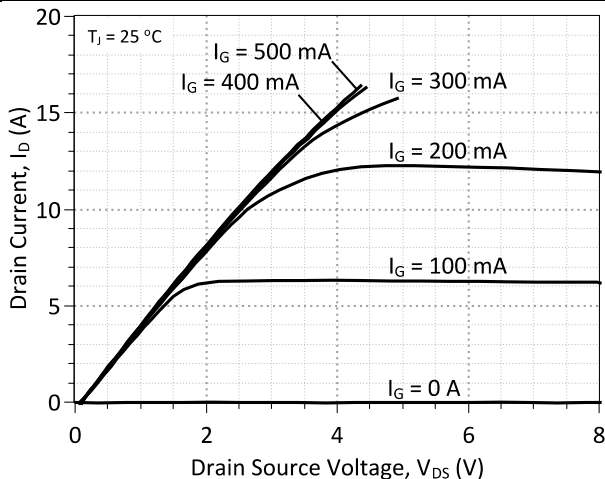
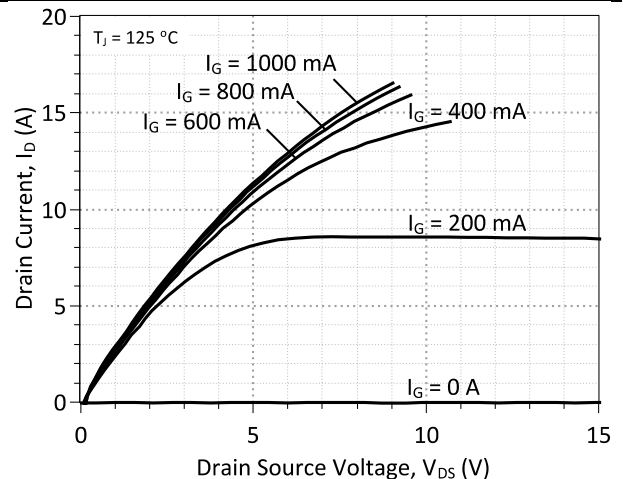
Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
On Characteristics						
Drain – Source On Voltage	$V_{DS(ON)}$	$I_D = 8 A$, $I_G = 500\text{ mA}$, $T_j = 25\text{ °C}$		2.0		V
		$I_D = 8 A$, $I_G = 1000\text{ mA}$, $T_j = 125\text{ °C}$		3.3		
		$I_D = 8 A$, $I_G = 1000\text{ mA}$, $T_j = 175\text{ °C}$		4.5		
Drain – Source On Resistance	$R_{DS(ON)}$	$I_D = 8 A$, $I_G = 500\text{ mA}$, $T_j = 25\text{ °C}$		250		mΩ
		$I_D = 8 A$, $I_G = 1000\text{ mA}$, $T_j = 125\text{ °C}$		400		
		$I_D = 8 A$, $I_G = 1000\text{ mA}$, $T_j = 175\text{ °C}$		550		
Gate Forward Voltage	$V_{GS(FWD)}$	$I_G = 500\text{ mA}$, $T_j = 25\text{ °C}$ $I_G = 500\text{ mA}$, $T_j = 175\text{ °C}$		3.0 2.8		V
DC Current Gain	β	$V_{DS} = 5 V$, $I_D = 8 A$, $T_j = 25\text{ °C}$ $V_{DS} = 5 V$, $I_D = 8 A$, $T_j = 175\text{ °C}$		65 40		
Off Characteristics						
Drain Leakage Current	I_{DSS}	$V_R = 1700 V$, $V_{GS} = 0 V$, $T_j = 25\text{ °C}$		0.1		μA
		$V_R = 1700 V$, $V_{GS} = 0 V$, $T_j = 125\text{ °C}$		0.5		
		$V_R = 1700 V$, $V_{GS} = 0 V$, $T_j = 175\text{ °C}$		2.0		
Gate Leakage Current	I_{SG}	$V_{SG} = 20 V$, $T_j = 25\text{ °C}$		20		nA

Electrical Characteristics at $T_j = 175\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit	
			min.	typ.	max.		
Capacitance Characteristics							
Gate-Source Capacitance	C_{GS}	$V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$		828		pF	
Input Capacitance	C_{ISS}	$V_{GS} = 0\text{ V}$, $V_D = 1\text{ V}$, $f = 1\text{ MHz}$		1070		pF	
Reverse Transfer/Output Capacitance	C_{RSS}/C_{OSS}	$V_D = 1\text{ V}$, $f = 1\text{ MHz}$		242		pF	
Switching Characteristics							
Turn On Delay Time	$t_{d(on)}$	$T_j = 25\text{ }^\circ\text{C}$, $V_{DD} = 1100\text{ V}$, $I_D = 8\text{ A}$, "Option #1" Gate Drive $R_{G(on)} = R_{G(off)} = 1.5\ \Omega$, $C_G = 9\text{ nF}$ $V_{GH} = 20\text{ V}$, $V_{GL} = 6\text{ V}$, $V_{EE} = -5\text{ V}$ $L = 1.05\text{ mH}$, FWD = GB05SLT12, Refer to Figure 15 for gate current waveform		10		ns	
Rise Time	t_r			10		ns	
Turn Off Delay Time	$t_{d(off)}$			39		ns	
Fall Time	t_f			48		ns	
Turn-On Energy Per Pulse	E_{on}			377		μJ	
Turn-Off Energy Per Pulse	E_{off}			96		μJ	
Total Switching Energy	E_{ts}			473		μJ	
Turn On Delay Time	$t_{d(on)}$		$T_j = 175\text{ }^\circ\text{C}$, $V_{DD} = 1100\text{ V}$, $I_D = 8\text{ A}$, "Option #1" Gate Drive $R_{G(on)} = R_{G(off)} = 1.5\ \Omega$, $C_G = 9\text{ nF}$ $V_{GH} = 20\text{ V}$, $V_{GL} = 6\text{ V}$, $V_{EE} = -5\text{ V}$ $L = 1.05\text{ mH}$, FWD = GB05SLT12, Refer to Figure 15 for gate current waveform		8		ns
Rise Time	t_r				8		ns
Turn Off Delay Time	$t_{d(off)}$				55		ns
Fall Time	t_f			44		ns	
Turn-On Energy Per Pulse	E_{on}			411		μJ	
Turn-Off Energy Per Pulse	E_{off}			86		μJ	
Total Switching Energy	E_{ts}			497		μJ	

Thermal Characteristics

Thermal resistance, junction - case	R_{thJC}	1.03	$^\circ\text{C/W}$
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Figures

Figure 1: Typical Output Characteristics at 25 °C

Figure 2: Typical Output Characteristics at 125 °C

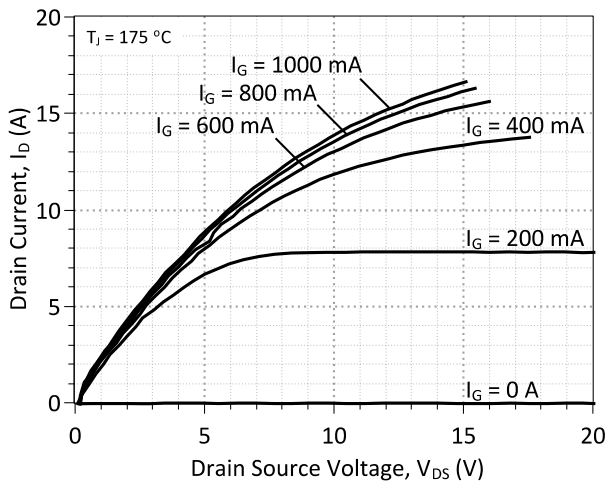


Figure 3: Typical Output Characteristics at 175 °C

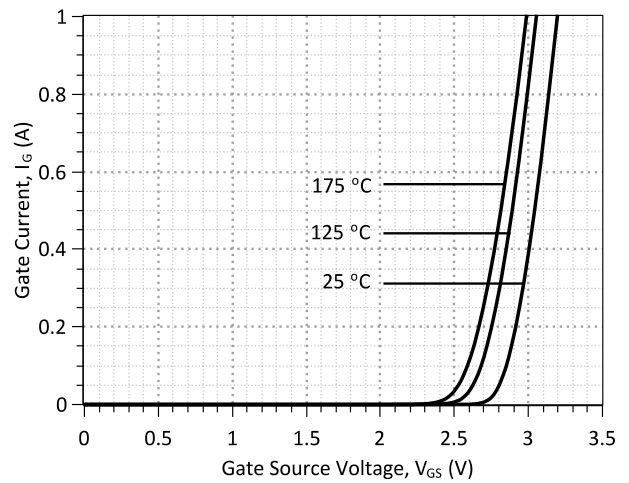


Figure 4: Typical Gate Source I-V Characteristics vs. Temperature

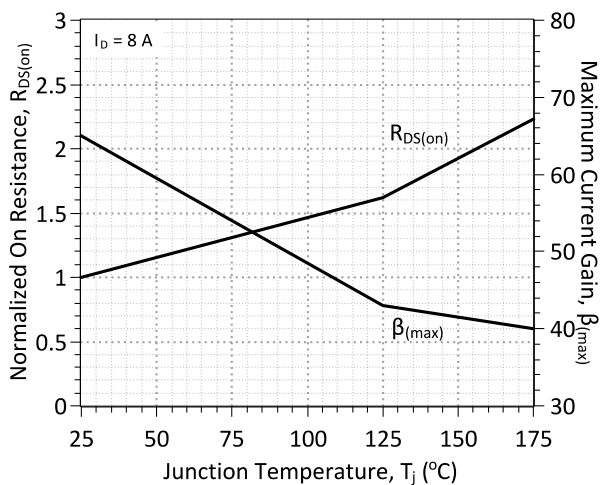


Figure 5: Normalized On-Resistance and Current Gain vs. Temperature

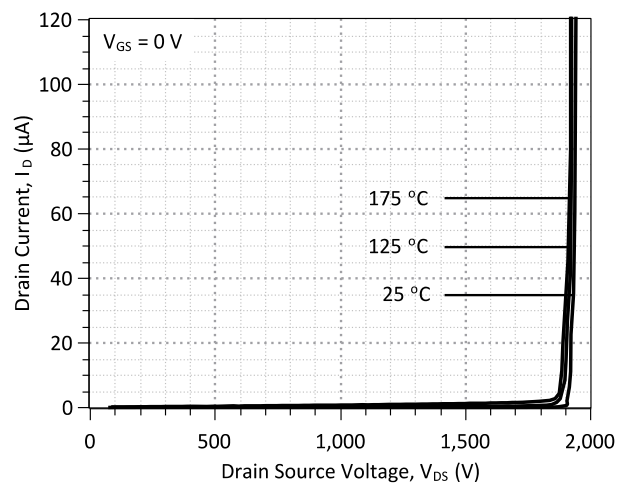


Figure 6: Typical Blocking Characteristics

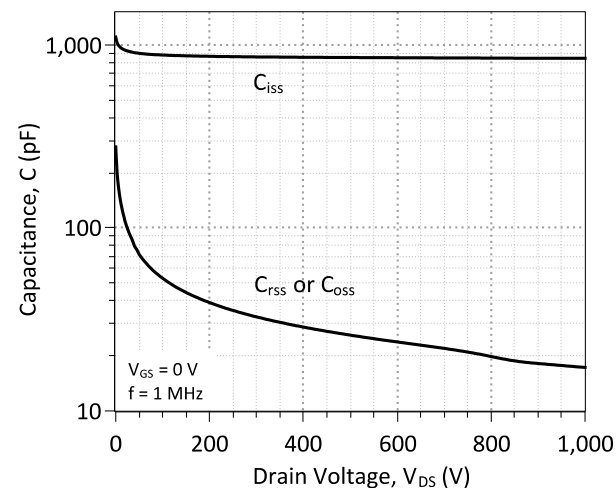


Figure 7: Capacitance Characteristics

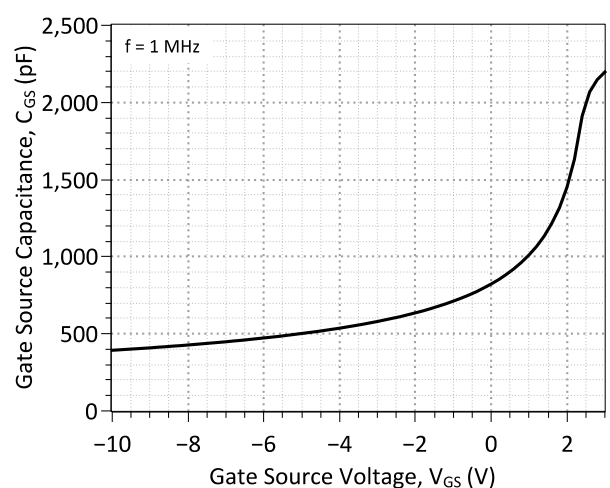


Figure 8: Capacitance Characteristics

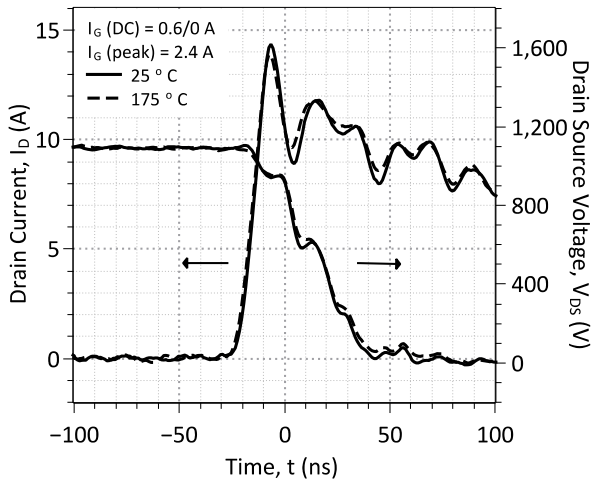


Figure 9: Typical Hard-switched Turn On Waveforms

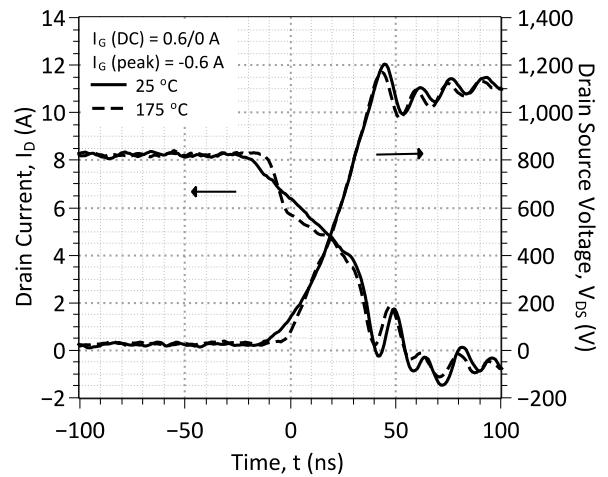


Figure 10: Typical Hard-switched Turn Off Waveforms

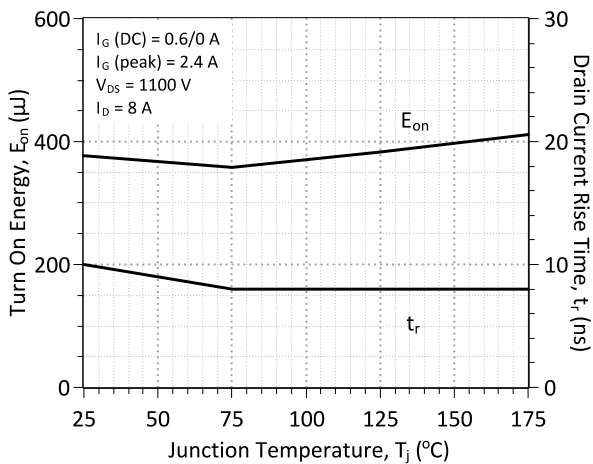


Figure 11: Typical Turn On Energy Losses and Switching Times vs. Temperature

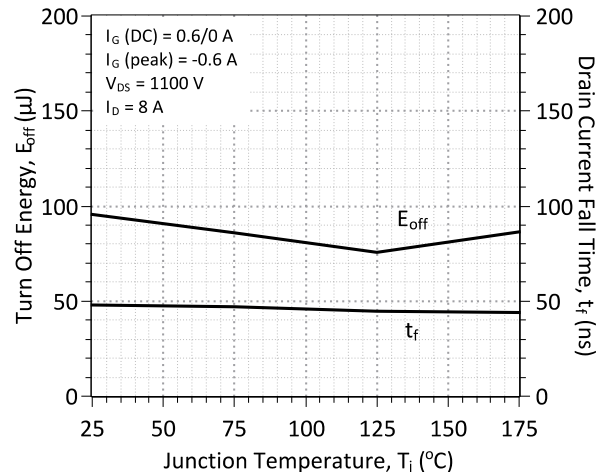


Figure 12: Typical Turn Off Energy Losses and Switching Times vs. Temperature

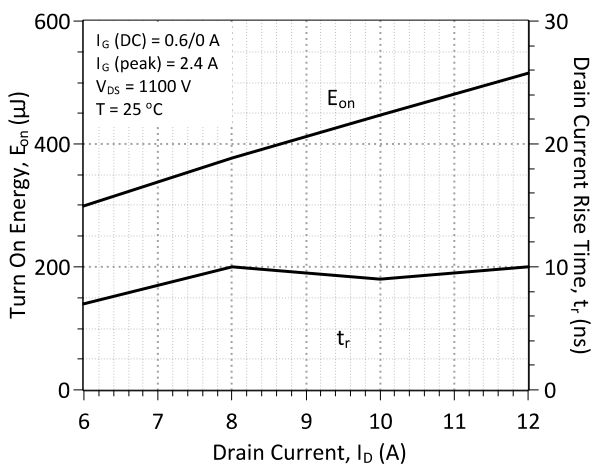


Figure 13: Typical Turn On Energy Losses vs. Drain Current

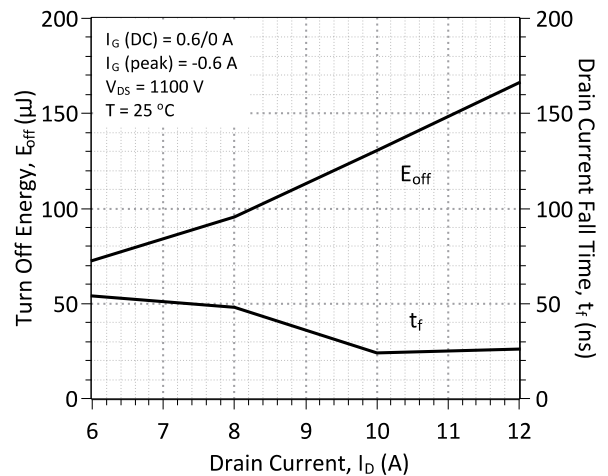


Figure 14: Typical Turn Off Energy Losses vs. Drain Current

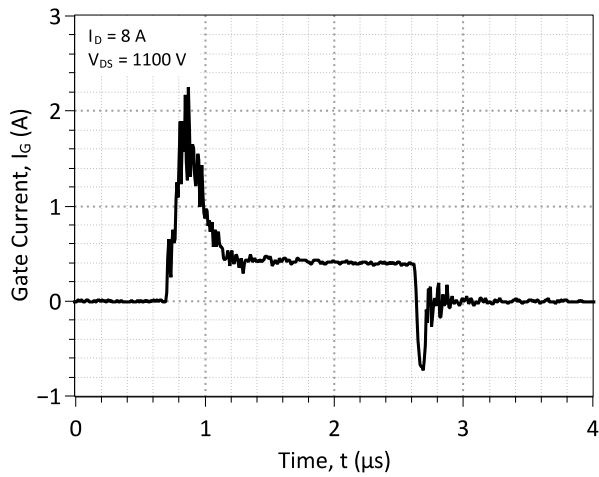


Figure 15: Typical Gate Current Waveform

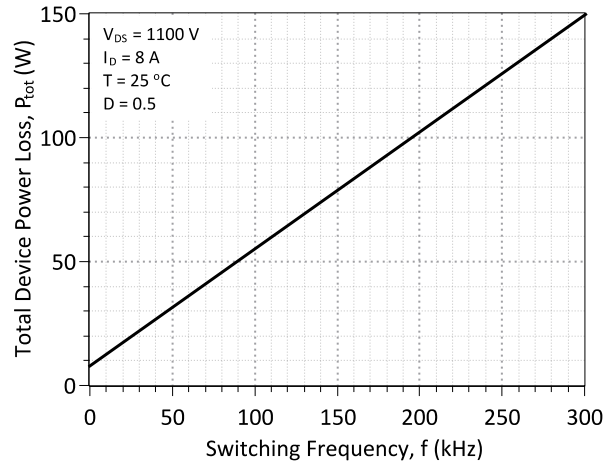


Figure 16: Typical Hard Switched Device Power Loss vs. Switching Frequency¹

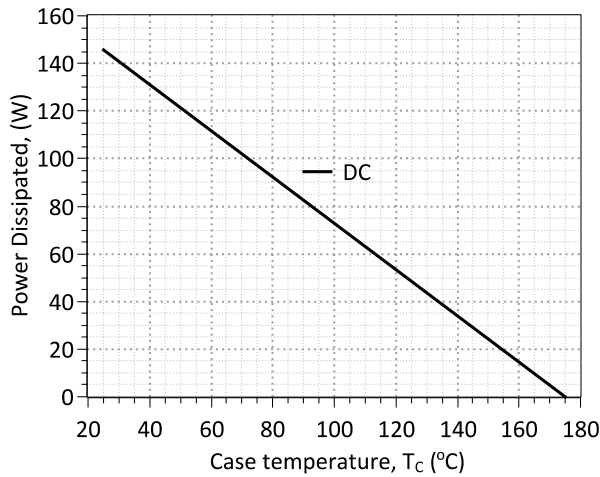


Figure 17: Power Derating Curve

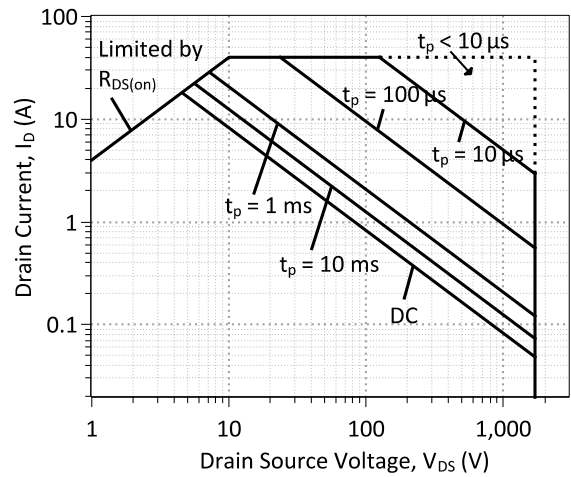


Figure 18: Forward Bias Safe Operating Area

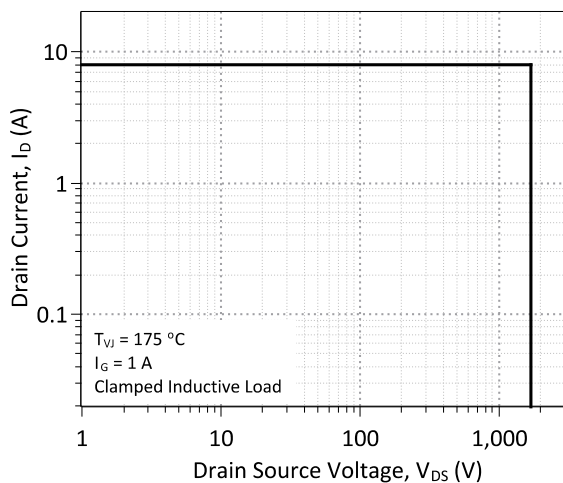


Figure 19: Turn-Off Safe Operating Area

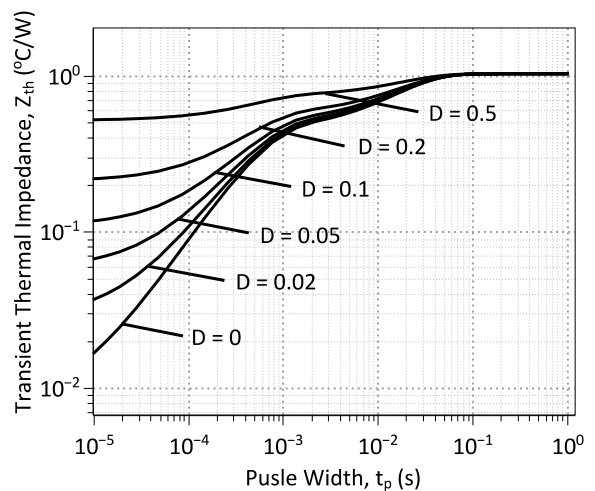


Figure 20: Transient Thermal Impedance

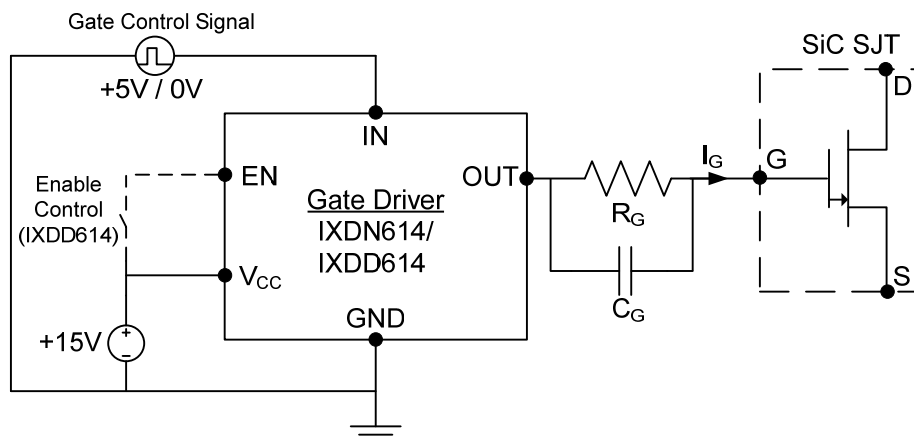
¹ – Representative values based on device switching energy loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.

Gate Drive Technique (Option #1)

To drive the GA08JT17-247 with the lowest gate drive losses, please refer to the dual voltage source gate drive configuration described in Application Note AN-10B (<http://www.genesicsemi.com/index.php/references/notes>).

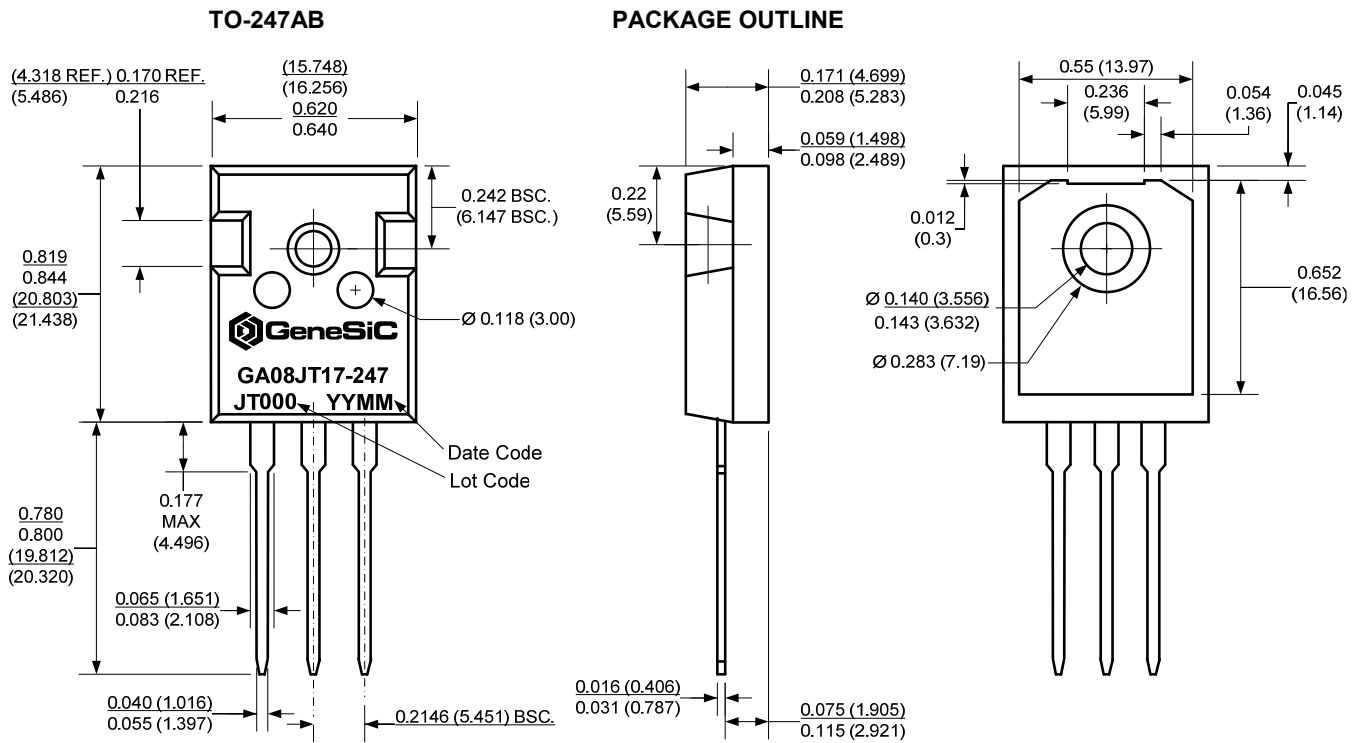
Gate Drive Technique (Option #2)

The GA08JT17-247 can be effectively driven using the IXYS IXDN614 / IXDD614 non-inverting gate driver IC or a comparable product. A typical gate driver configuration along with component values using this driver is offered below. Additional information is available in GeneSiC Application Note AN-10A and from the manufacturer at www.ixys.com.


Figure 21: Gate Diver Configuration (Option #2)

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Option #1 Gate Drive Conditions (IXDD614/IXDN614)						
Supply Voltage, High Side Driver	V_{CC}	V_{GH}	-0.3	20	30	V
Supply Voltage, Low Side Driver	V_{CC}	V_{GL}	5.0	6.0		V
Off State Voltage, Both Drivers	GND	V_{EE}		-5	0	V
Gate Control Input Signal, Low	IN		-5.0	0	0.8	V
Gate Control Input Signal, High	IN		4.0	5.0	$V_{CC}+0.3$	V
Enable, Low	EN	IXDD614 Only			$1/3 * V_{CC}$	V
Enable, High	EN	IXDD614 Only		$2/3 * V_{CC}$		V
Output Voltage, Low	V_{OUT}				0.025	V
Output Voltage, High	V_{OUT}		$V_{CC}-0.025$			V
Output Current, Peak	I_{OUT}	Package Limited		4.5	14	A
Output Current, Continuous	I_{OUT}			0.5	4.0	A
Passive Gate Components						
Gate Resistance	R_G	$V_{GL} = 6.0 \text{ V}, I_G \approx 0.5 \text{ A}$		1.6	5	Ω
Gate Capacitance	C_G	$V_{GH} = 20 \text{ V}, I_{G,pk} \approx 2.0 \text{ A}$	5	9		nF

Package Dimensions:



- NOTE**
1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History			
Date	Revision	Comments	Supersedes
2013/08/27	3	Updated Switching Characteristics	
2013/06/24	2	Updated Electrical Characteristics	
2013/02/21	1	Switching Data Added	
2012/12/03	0	Initial release	

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SPICE Model Parameters

Copy the following code into a SPICE software program for simulation of the GA08JT17 SJT device.

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*      MODEL OF GeneSiC Semiconductor Inc.
*
*      $Revision:   1.0           $
*      $Date:      26-AUG-2013   $
*
*      GeneSiC Semiconductor Inc.
*      43670 Trade Center Place Ste. 155
*      Dulles, VA 20166
*      http://www.genesicsemi.com/index.php/sic-products/sjt
*
*      COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
*      ALL RIGHTS RESERVED
*
*      These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
*      OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
*      TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
*      PARTICULAR PURPOSE."
*      Models accurate up to 2 times rated drain current.
*
.model GA08JT17 NPN
+ IS      3.73E-47
+ ISE     5.50E-27
+ EG      3.2
+ BF      49.5
+ BR      0.55
+ IKF     200
+ NF      1
+ NE      2.021
+ RB      0.26
+ RE      0.103394007
+ RC      0.151605993
+ CJC     2.77E-10
+ VJC     3.023103628
+ MJC     0.460762158
+ CJE     8.23E-10
+ VJE     2.945448229
+ MJE     0.498044294
+ XTI     3
+ XTB     -0.7
+ TRC1    7.50E-3
+ VCEO    1700
+ ICRATING 8
+ MFG      GeneSiC_Semiconductor
*
*      End of GA08JT17 SPICE Model
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